

JUL 07 2005

S/N 10/661,234PATENT**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE***Sent Via Fax To: 703-872-9306 & 571-273-2315*

Applicant: John A. Moon et al.
Serial No.: 10/661,234
Filed: September 12, 2003
Title: Diffraction Grating-Based Optical Identification Element

Examiner: Arnel C. Lavarias
Group Art Unit: 2828
Docket: CV-0038A US

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

In compliance with the duty imposed by 37 C.F.R. § 1.56, and in accordance with 37 C.F.R. §§ 1.97 *et. seq.*, the referenced materials are brought to the attention of the Examiner for consideration in connection with the above-identified patent application. Applicants respectfully request that this Supplemental Information Disclosure Statement be entered and the documents listed on the attached Form 1449 be considered by the Examiner and made of record. Pursuant to the provisions of MPEP 609, Applicants request that a copy of the 1449 form, initialed as being considered by the Examiner, be returned to the Applicants with the next official communication.

Pursuant to 37 C.F.R. § 1.97(c)(2), Please Charge the fee of \$180.00 as set forth in 37 C.F.R. § 1.17(p) and any additional fees or credit any overpayment to Deposit Account No. 50-2994.

The Examiner is invited to contact the Applicants' Representative at the below-listed contact information if there are any questions regarding this communication.

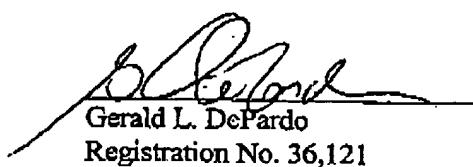
In accordance with the Patent and Trademark Office's waiver of the requirement under 37 C.F.R. § 1.98(a)(2)(i), copies of the listed U.S. patents are not enclosed because the current application has been filed after June 30, 2003.

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In accordance with the waiver of 37 C.F.R. § 1.98(a)(2)(i) for submitting a copy of each cited U.S. patent and publication for all U.S. national patent applications filed after June 30, 2003, only copies of the foreign references and other documents are enclosed.

Respectfully submitted,



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Substitute for form 1449A/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT <small>(Use as many sheets as necessary)</small>		Approved for use through 07/31/2008. GSA FPMR (41 CFR) 101-11.7(e)(2) US Patent & Trademark Office; U.S. DEPARTMENT OF COMMERCE <small>Under the Paperwork Reduction Act of 1995, no person is required to respond to a collection of information unless it contains a valid OMB control number.</small>	
		Complete if Known.	
		Application Number	10/661,234
		Filing Date	September 12, 2003
		First Named Inventor	Moon, John
		Group Art Unit	2828
		Examiner Name	Arnel C. Lavarrias
Sheet 1 of 1		Attorney Docket No: CV-0038A US	

US PATENT DOCUMENTS					
Examiner Initials	Cite No.	USP Document Number	Publication Date	Name of Patentee or Applicant of cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		US-20020039732A1	04/04/2002	Bruchez, M. P., et al.	
		US-3,891,302	06/24/1975	Dabby, Franklin W., et al.	
		US-3,916,162	10/28/1975	Dabby, Franklin W., et al.	
		US-4,725,110	02/16/1988	Glenn, William H., et al.	
		US-4,807,950	02/28/1989	Glenn, William H., et al.	
		US-5,367,588	12/22/1994	Hill, Kenneth O., et al.	
		US-5,388,173	02/07/1995	Glenn, William H.	
		US-5,745,815	04/28/1998	Atkins, R. M., et al.	

FOREIGN PATENT DOCUMENTS					
Examiner Initials	Cite No.	Foreign Document No	Publication Date	Name of Patentee or Applicant of cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Country Code – Number – Kind Code (if known)			T ²
		WO-WO03/061983	07/31/2003	Steenblick, Richard A.	

OTHER DOCUMENTS -- NON PATENT LITERATURE DOCUMENTS		
Examiner Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
		JAIN, K. K., "Nanodiagnostics: Application of Nanotechnology in Molecular Diagnostics", <u>Expert Review of Molecular Diagnostics</u> , 3 (2), Future Drugs Ltd.,(Mar., 2003),153-161
		OTHONOS, A. , et al., "Superimposed Multiple Bragg Gratings", <u>Electronics Letters</u> , 30, (Nov. 10, 1994),1972-1974
		YUEN, P. K., et al., "Microbarcode Sorting Device", <u>Lab on a Chip</u> , Vol. 03 (3), The Royal Society of Chemistry 2003,(Aug. 2003),198-201

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 604. DASH line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. 1. Applicant's unique citation designation number (optional) 2. Applicant is to place a check mark here if English language translation is attached